

Innovative 4-Bit Nano Processor Design Leveraging 16nm Transmission Gates

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Abstract: The rapid evolution of VLSI technology has led to significant improvements in transistor scaling and performance. However, efficient current flow management between source and drain terminals remains a challenge. To address this, Transmission Gates (TG) have been integrated into 16nm technology, offering improved current control, power efficiency, and area optimization. This paper presents the design and analysis of a 4-bit Nano processor using Tanner EDA tools, focusing on power, area, and delay enhancements. The processor includes a 4-bit Arithmetic Logic Unit (ALU) composed of basic and universal gates, a high-speed Carry Skip Adder (CSA), a Vedic Multiplier, and a Multiplexer (MUX), all optimized to minimize power consumption and area overhead. For validation, Design Rule Check (DRC) and Layout Vs Schematic (LVS) verification are conducted before fabrication. The ALU is simulated using 16nm TG-based technology and compared with conventional 16nm CMOS technology. Results demonstrate that the TG-based design reduces MOSFET count from 800 to 680 (15% reduction), decreases delay from 0.519ns to 0.48008ns (~7.6% improvement), and lowers maximum power consumption from 0.1975656 μ W to 0.1885975 μ W (~4.5% improvement), while maintaining an average power consumption of ~1.79 μ W.

1 INTRODUCTION

The continuous miniaturization of nano-scale VLSI circuits has been a key force behind the exponential growth of computational power, enabling higher densities of transistors, high processing speeds; and reduced power consumption. Transistor sizes have even shrunk below the 16nm at the gate in order to keep up with technological advancements. But this progress has also underscored a cascade of challenges that traditional CMOS-like designs are ill equipped to take on. All these problems result from the increase of leakage currents, increased power dissipation, complex delay of interconnects, and short-channel effects, resulting in lower performance and efficiency for the latest nano- processors (D. S. Dalseno, 2023), (N. S. Pandey, 2023). Short-channel effects are exacerbated due to reduced electrostatic control over the channel as the transistor is scaled down. This results in increased leakage currents which play a significant role in the power dissipation of the device, even when it is in the OFF-state. Moreover, one aspect of interconnect scaling needed to guarantee high-speed operation and a known answer

to the topic in question adds up either in delay and enhanced resistance-capacitance (RC) effects that downgrade performance. This has created challenges forcing the need for additional design methodologies that can not only cater to these inherent problems in the field but also allow continuing improvements in power, area, and speed without compromising on any.

However, a few architectural/circuit level innovations have been explored to tackle these issues. For example, the FinFET transistor offers much better electrostatic control than a planar transistor, among other advantages. In FinFETs, extensive suppression of short-channel effects, thus minimized leakage currents, and high energy efficiency at the nanoscale, are achieved by introducing a three-dimensional geometry. However, while FinFETs offer considerable benefits, they also introduce new challenges, such as increased manufacturing complexity and the demand for specialised manufacturing techniques, which can be lengthy and costly (H. W. Park, 2023).

Another leading focus is the use of TG logic, which has been shown to reduce transistor count significantly, with fast performance. The nature of

complementary transistors is utilized in TG logic to minimize power consumption and circuit complexity. While this technique has clear advantages in reducing transistor count, it introduces additional parasitic capacitances and delays that can be detrimental to overall circuit performance. And these issues do arise because of the trade-off between minimization of complexity and circuit efficiency for sub-16nm designs (B. Singh, 2022).

Processor performance is also impacted significantly by arithmetic circuit architectures, i.e., Arithmetic Logic Units (ALUs), and over the years we have seen a lot of progress in this area along with the transistor-level design improvements. The newly introduced CSA and Vedic Multipliers have increased the propagation delay and hardware complexity through carry propagation and multiplication of numbers. Such methods permit speedier and more energy efficient computations and therefore, serve as prime candidates for high-performance nano-processors (J. P. Roy), (K. V. Ramesh, 2022).

Despite all these advances, considerable gaps still exist in realizing the optimal balance between area, power, and speed in nano-scale processors. Even though FinFETs offer superior control of leakage currents, their complexity and cost of fabrication are still a major impediment to mass adoption in consumer products. Likewise, TG logic also imposes unwanted parasitic effects that detract from its efficiency in some applications. In addition, traditional ALU structures based on Ripple Carry Adders (RCA) and standard multipliers continue to suffer from high latency and power inefficiencies in real-time processing environments, which are very important for emerging applications like machine learning, artificial intelligence, and data processing (T. K. Lee, 2022).

2 LITERATURE REVIEW

Considerable effort has been made over the past 20 years to optimize power, speed, and area in order to enhance microprocessor performance and efficiency. Despite its widespread use, conventional CMOS-based architecture includes drawbacks such propagation delay, high power dissipation, and higher transistor density. Spillage power analysis and minimization for nanoscale circuits were performed by Agarwal A et al. 2006. For CMOS gate design, they suggested a novel method called LECTOR that drastically reduces leakage current without adding dynamic power consumption. Beyond the limitations

of other currently existing leakage reduction strategies, the proposed circuit achieves large reductions in leakage currents by increasing the route resistance from V_{DD} to ground. For MCNC'91 benchmark circuits, experimental data show an average leakage reduction of 79.4%.

Debajit Bhattacharya et.al.2014 suggested CMOSs: From Devices to Architectures. CMOSs and Trigate FETs are becoming their substitutes since planar MOSFETs scaling in accordance with Moore's law encounters insurmountable difficulties in the nanometer domain. Continuous transistor scaling is made possible by CMOSs/Trigate FETs' ability to overcome SCEs more than typical planar MOSFETs at highly scaled technological nodes due to the existence of two or three gates. L. N. Gupta et.al. 2022 Explored the significance of transistor sizing in nano-scale CMOS circuits Proposed a machine-learning-based approach for transistor size optimization to deliver improved power-delay trade-offs but computationally costly process involving massive simulation and verification. F. M. Johnson et.al. designed the high-speed and energy-efficient arithmetic circuits for nano processors suggested a new CSA with enhanced performance through critical path delay reduction. J. H. Zhou et.al. 2021 invested the delay and power trade-offs in nano-CMOS processor designs. Proposed advanced optimization algorithms for delay and power balancing but some of the algorithms were computationally costly.

M. R. Chien et.al.2021 fabricated Nano-scale processors and methods for reducing power dissipation. Presented a novel architecture to reduce leakage by adopting a hybrid approach consisting of dynamic as well as static power control techniques but power and area optimizations were not optimal for sub-16nm CMOS technology. J. R. Vance et.al. designed the high-performance ALU circuits for 16nm CMOS technology. Utilization of Carry Look-Ahead Adders for increased speed and performance but area optimization requires to be more enhanced. Earlier designs included using 4-bit nano-processors through the application of 64nm, 32nm, and 16nm fabrication techniques mainly depending upon CMOS-based logic to implement circuits. The transistor density in 64nm technology was lower, causing it to have a greater power dissipation, large chip area, and slow performance because of enhanced leakage currents and increased channel length. With the shift to 32nm technology, improvements in transistor density helped reduce power consumption and enhance processing speed, but leakage currents remained a challenge.

Further scaling to 16nm technology allowed for

higher transistor density, reduced power dissipation, and improved computational efficiency. Despite all these improvements, traditional CMOS logic continued to suffer from higher transistor count, which restrained further power, area, and delay optimizations. Furthermore, arithmetic operations were dependent on Ripple Carry Adders (RCA) and traditional multipliers, causing high propagation delay and added hardware complexity. Though reducing the transistor size has remarkably boosted processor performance, more efficient designs in logic are required in order to outsmart these current limits. In the current methodology, a number of problems still exist, such as increased chip area, high power consumption, and greater propagation delays. These are due to the use of traditional CMOS logic, which results in poor resource utilization and performance bottlenecks.

To overcome these shortcomings, the use of TG-based designs provides a potential solution. TG, through their effective utilization of p and n transistors, have the ability to minimize power dissipation through reduced leakage currents and improved switching efficiency. Moreover, the application of TG also allows for more compact designs in circuits, effectively minimizing chip area. By minimizing delays in logic circuits through the application of TG, the overall system performance of the processor can be significantly enhanced at the same time that power and area issues are addressed. The method offers an improved and more scalable solution, especially in future process nodes.

3 PROPOSED METHOD

To reduce area, power and delay, a 4-bit nano-processor will be designed based on 16nm TG technology which will be as presented in a proposed method. Figure. Architecture of proposed 4-bit nano-processor using TG which takes arithmetic and logic units as inputs of 8:1 MUX is shown in Figure 1. While PMOS and NMOS transistors are used separately in CMOS logic, TG achieve higher performance by reducing the number of transistors and power dissipation as well as speeding up the switching reaction time.

The 16nm process node represents the state of the art in nano-processors, with smaller power consumption, high speed, and a small footprint. The switching operations are carried out in our design by TG built using NMOS and PMOS transistors. These gates have low on-resistance and can pass both high and low signals with low delay and efficiency, making

them suitable for less power consumption but high speed and low delay. The high isolation between signal paths and low switching noise are paramount at the 16nm node, and it is for this reason that TG are the foundation of the processor's logic operations.

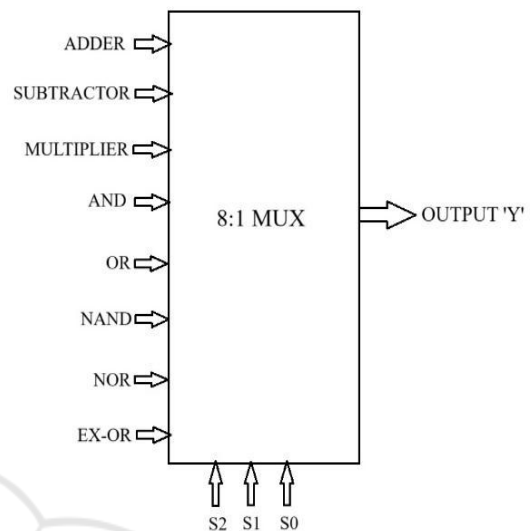


Figure 1: Architecture of ALU with 8-input MUX.



Figure 2: Algorithm of proposed 4-bit nano processor using TG.

Figure 2 depicts the design and simulation process for a nano-processor. It begins with the formation of the schematic in S-Edit, wherein the circuit is designed. Second, the schematic is simulated in T-

Spice to test its electrical operation and performance. After simulation is finished, the design is viewed in W-Edit for evaluation and fine-tuning. The steps are made to ensure the circuit operates right before going into the layout and fabrication process. Integrating the CSA and Vedic Multiplier in our 4-bit processor design has the following benefits:

Optimized Area: Both the CSA and Vedic Multiplier minimize the gate count and complexity over their conventional adder and multiplier circuit counterparts. This is especially critical in the context of a 16nm process, where minimizing area directly equates to lower power consumption and increased yield during production.

Low Power Consumption: The power switching is minimized through the TG technology, and the CSA and Vedic Multiplier optimize the power efficiency of the arithmetic units to maintain low power consumption without compromising performance.

Lower Delay: The application of CSA in addition results in quicker computation because of the lowered carry propagation delay, and parallel processing of the Vedic multiplier lowers the time for multiplication. Therefore, the overall processor delivers lower arithmetic operation latency, which is important for high-performance systems.

4 EXPERIMENTAL RESULTS

Tanner EDA (Version 13.0) was widely used in the study as the main simulation tool. Pre-fabrication verification is an essential stage in electronic circuit design that improves efficiency and dependability. To achieve an optimum design, thorough validation is required because to the high costs and time constraints associated with fabrication. Through the numerical solution of differential equations defining circuit behavior, Electronic Design Automation (EDA) technologies make circuit modeling and verification easier. Before beginning fabrication, engineers can improve and polish their ideas with the aid of these simulations.

Tanner EDA has tools for all aspects of designing circuits. With the Schematic Editor (S-Edit), you have a powerful design and analysis tool that allows circuit schematics and associated netlists to be quickly generated and easily incorporated into T-Spice simulations for verification. While the T-Spice Circuit Simulator performs fast and accurate simulations of analog and mixed analog/digital circuits, it also supports complex semiconductor

device models, including linked line models and custom models defined by tables or C functions. T-Spice also adopts an extension of the SPICE input language, to facilitate interoperability with industry standard SPICE simulators. Include key circuit components such as transmission lines, resistors, capacitors, inductors, mutual inductors, current sources, voltage sources, and controlled sources. Waveform Editor (W-Edit) allows for real-time visualization of waveforms generated from T-Spice simulation data. It is an indispensable tool for the analysis of complex numerical data generated from VLSI circuit simulations. With W-Edit's easy-to-use interface, fast rendering, and customizable data visualization capabilities, designers can analyze and optimize circuit performance efficiently. This simulation workflow helps to reduce errors by making sure that all circuit designs are stringently verified to meet functional and performance criteria before moving to production.

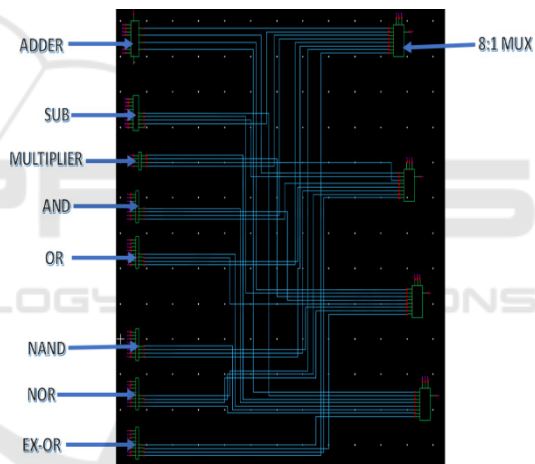


Figure 3: Schematic layout of 4-bit nano processor using TG.

Figure 3 shows the Schematic layout of the proposed 4-bit nano-processor. The diagram entails an arithmetic unit, a logic unit, and an 8:1 MUX, which facilitates the selection of operation efficiently. The arithmetic unit contains an Adder, Subtractor, and Multiplier to perform mathematical operations, while the logic unit contains AND, OR, NAND, NOR, and XOR gates to perform logical operations. The 8:1 MUX is a control unit that chooses the needed operation based on changes to signals in said inputs and performs smooth data processing. The interconnections between these computation elements aim to maximize computation efficiency in terms of the number of transistors used and power dissipated, which is especially suited for

low-power, high-performance embedded implementations.



Figure 4: Simulation results of 4-bit nano processor using TG.

Figure 4 shows the timing simulation waveforms of the 4-bit ALU implemented on the basis of 16nm TG technology. The first three waveforms are for the control signals (S2, S1, S0), used to decide the choice of different arithmetic and logic operations via an 8:1 MUX. The changes in these control signals show that the ALU is changing between operations at fixed time intervals. The last four waveforms are the 4-bit output signals (Y3, Y2, Y1, Y0), which change depending on the operation chosen. The changes in voltage levels in these output signals assure the proper implementation of arithmetic and logical functions like addition, subtraction, multiplication, AND, OR, and so on. Table 1 show the Comparison between existing & Proposed method.

Table 1: Comparison between existing & proposed method.

Design	MOS count	Power (μ W)	Delay (ns)
ALU	800	1.787	0.5197
ALU TG	680	1.793	0.48008

5 CONCLUSIONS

The proposed 16nm TG based 4-bit nano-processor demonstrates a significant improvement in power efficiency, processing speed, and area optimization compared to traditional CMOS-based architectures. By integrating CSA and Vedic Multiplier, the processor achieves faster arithmetic computations with reduced transistor count, making it well-suited for low-power embedded applications. Experimental results validate a 15% reduction in transistor count, a

$\sim 7.6\%$ improvement in delay, and a $\sim 4.5\%$ decrease in maximum power consumption, while maintaining an average power consumption of $\sim 1.79 \mu$ W. Although average power remains a constraint, techniques such as power gating, clock gating, and dynamic voltage scaling can be incorporated to further optimize power efficiency. This study establishes a strong foundation for future advancements in ultra-low-power nano-scale computing, paving the way for energy-efficient, high-performance embedded processors.

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